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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/846,750	ARQUIE ET AL.	
Examiner	Art Unit	
Lo Nauvon	2174	

SEARCHED			
Class	Subclass	Date	Examiner
715	734	7/27/2007	LVN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	ib, USPAT: 5/734	7/27/2007	LVN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
reviewed description of computer- readable medium	7/27/2007	LVN	
inventor name search	7/27/2007	LVN	